Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/550,202	TANAKA ET AL.	
Examiner	Art Unit	
Sang Y Paik	3742	

SEARCHED			
Class	Subclass	Date	Examiner
372	416-		
	418		
249	40-		
	J14,		
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113	1724		
	725	Marlin	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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